


<b>Search Notes</b> 	<b>Application/Control No.</b> 10813974	<b>Applicant(s)/Patent Under Reexamination</b> HUEY, CHRISTOPHER A.
	<b>Examiner</b> Nguyen, Khai N	<b>Art Unit</b> 2614

SEARCHED			
Class	Subclass	Date	Examiner
379	114.02, 211.02;	7/05/2007	
455	414	7/05/2007	KNN
379; 455	Updated the above searches	12/1/2008	KNN
379; 455	Updated the above searches.	06/01/2009	KNN
379; 455;	Updated the above searches.	03/11/2010	KNN
379; 455	Updated the above searches.	08/25/2010	KNN

SEARCH NOTES		
Search Notes	Date	Examiner
East - USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	7/05/2007	KNN
Internet - NPL Search	7/05/2007	KNN
Updated East and NPL searches	12/1/2008	KNN
Updated East and NPL searches.	06/01/2009	KNN
Updated East & NPL searches.	03/11/2010	KNN
Updated East & NPL searches.	08/25/2010	KNN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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